

AON1620

12V N-Channel MOSFET

General Description

The AON1620 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{\text{DS(ON)}}.$ This device is ideal for load switch and battery protection applications.

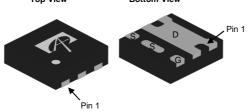
Product Summary

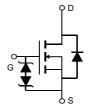
 $\begin{array}{lll} V_{DS} & 12V \\ I_{D} & (at \ V_{GS}{=}4.5V) & 4A \\ R_{DS(ON)} & (at \ V_{GS} = 4.5V) & < 22m\Omega \\ R_{DS(ON)} & (at \ V_{GS} = 2.5V) & < 27m\Omega \\ R_{DS(ON)} & (at \ V_{GS} = 1.8V) & < 36m\Omega \end{array}$

Typical ESD protection HBM Class 2









Absolute Maximum Ratings T_A=25℃ unless otherwise noted Parameter Symbol Maximum Units Drain-Source Voltage V_{DS} ٧ Gate-Source Voltage ±8 V_{GS} Continuous Drain T_A=25℃ 4 I_D Current G T_A=70℃ 3 Α Pulsed Drain Current C 16 I_{DM} T_A=25℃ 1.8 P_D W T_A=70℃ Power Dissipation A 1.15 Junction and Storage Temperature Range T_J , T_{STG} -55 to 150 ${\mathfrak C}$

Thermal Characteristics									
Parameter		Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	56	70	°C/W				
Maximum Junction-to-Ambient AD	Steady-State	$\kappa_{\theta JA}$	88	110	°C/W				



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
STATIC I	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		12			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =12V, V _{GS} =0V				1	μΑ
	Zero Gate Voltage Drain Gurrent					5	
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±8V				±10	μΑ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		0.4	0.7	1.0	V
$I_{D(ON)}$	On state drain current	V_{GS} =4.5V, V_{DS} =5V		16			Α
R _{DS(ON)} Static Dr		V_{GS} =4.5V, I_D =4A			18	22	mΩ
			T _J =125℃		23.5	29	11152
	Static Drain-Source On-Resistance	V_{GS} =2.5V, I_D =3A			21	27	mΩ
		V _{GS} =1.8V, I _D =2A			27	36	mΩ
		V_{GS} =1.5V, I_D =1A		35		mΩ	
g _{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=4A$			25		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.65	1	V
Is	Maximum Body-Diode Continuous Current					2.5	Α
DYNAMI	CPARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =6V, f=1MHz			770		pF
Coss	Output Capacitance				180		pF
C _{rss}	Reverse Transfer Capacitance				130		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			1.2		Ω
SWITCH	NG PARAMETERS						
Q _g (4.5V)	Total Gate Charge	V _{GS} =4.5V, V _{DS} =6V, I _D =4A			8	12	nC
Q_{gs}	Gate Source Charge				1		nC
Q_{gd}	Gate Drain Charge				2		nC
t _{D(on)}	Turn-On DelayTime				2.5		ns
t _r	Turn-On Rise Time	V_{GS} =4.5V, V_{DS} =6V, R_L =3.75 Ω , R_{GEN} =3 Ω			3.5		ns
t _{D(off)}	Turn-Off DelayTime				25		ns
t _f	Turn-Off Fall Time	7			4		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =4A, dI/dt=100A/μs			10		ns
Q _{rr}	Body Diode Reverse Recovery Charge	l _F =4A, dl/dt=100A/μs			3		nC

A. The value of R_{BJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R _{BJA} t ≤ 10s value and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J(MAX)}=150^\circ$ C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =150° C. Ratings are based on low frequency and duty cycles to keep initial $T_J = 25^{\circ} C$.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

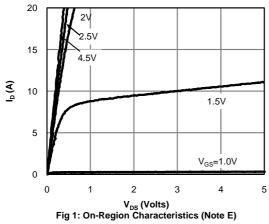
E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

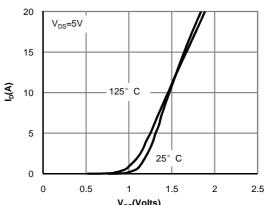
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating. G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

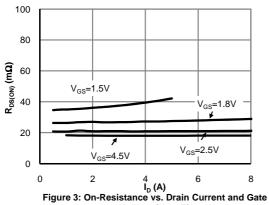


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

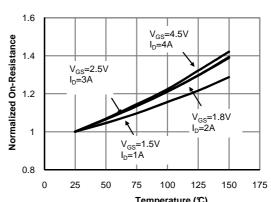




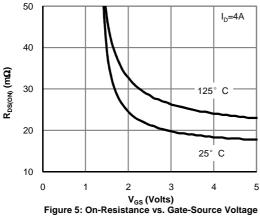
V_{GS}(Volts)
Figure 2: Transfer Characteristics (Note E)



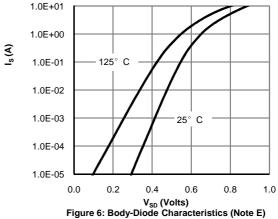
Voltage (Note E)



Temperature (℃)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



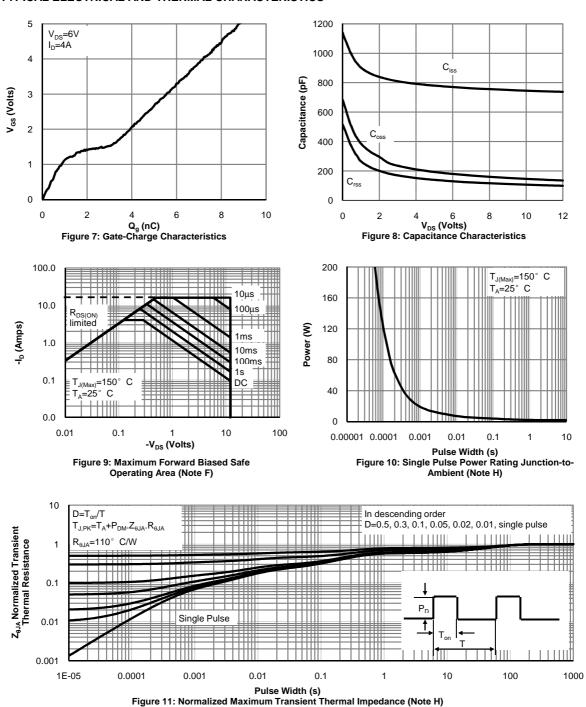
(Note E)



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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

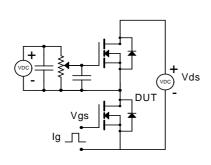


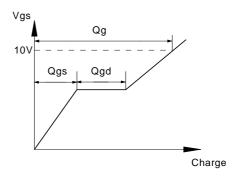
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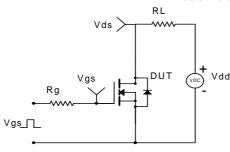


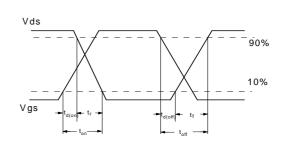
Gate Charge Test Circuit & Waveform



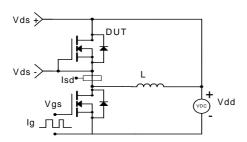


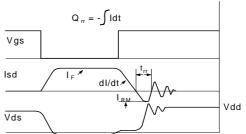
Resistive Switching Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms





单击下面可查看定价,库存,交付和生命周期等信息

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